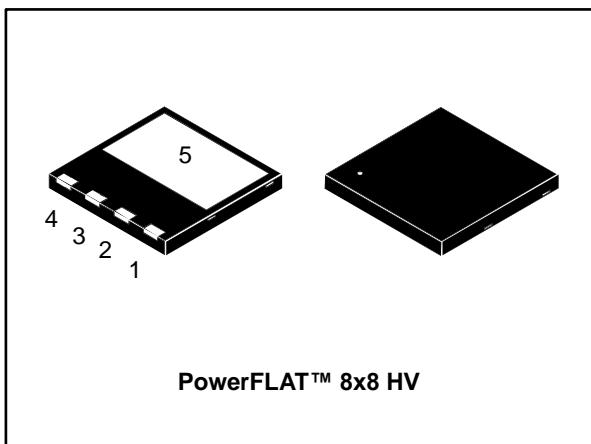
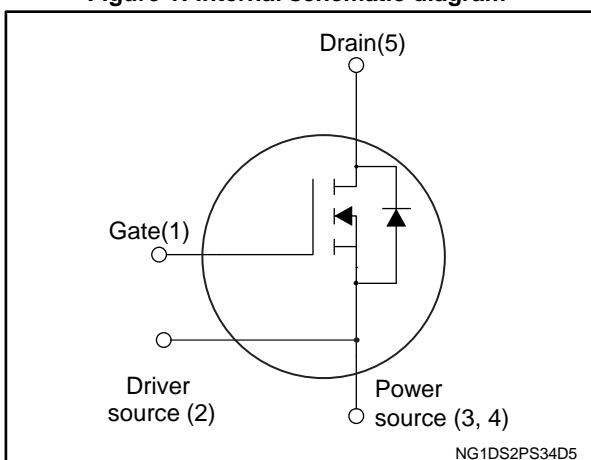


## N-channel 650 V, 0.061 Ω typ., 22.5 A MDmesh™ M5 Power MOSFET in a PowerFLAT™ 8x8 HV package

Datasheet - production data



**Figure 1: Internal schematic diagram**



### Features

Order code	V <sub>DS</sub> @ T <sub>Jmax</sub>	R <sub>DS(on)</sub> max.	I <sub>D</sub>
STL57N65M5	710 V	0.069Ω	22.5 A

- Extremely low R<sub>DS(on)</sub>
- Low gate charge and input capacitance
- Excellent switching performance
- 100% avalanche tested

### Applications

- Switching applications

### Description

This device is an N-channel Power MOSFET based on the MDmesh™ M5 innovative vertical process technology combined with the well-known PowerMESH™ horizontal layout. The resulting product offers extremely low on-resistance, making it particularly suitable for applications requiring high power and superior efficiency.

**Table 1: Device summary**

Order code	Marking	Package	Packing
STL57N65M5	57N65M5	PowerFLAT™ 8x8 HV	Tape and reel

## Contents

<b>1</b>	<b>Electrical ratings.....</b>	<b>3</b>
<b>2</b>	<b>Electrical characteristics .....</b>	<b>4</b>
2.1	Electrical characteristics (curves).....	6
<b>3</b>	<b>Test circuits .....</b>	<b>9</b>
<b>4</b>	<b>Package information .....</b>	<b>10</b>
4.1	PowerFLAT™ 8x8 HV package information.....	11
4.2	PowerFLAT™ 8x8 HV packing information.....	13
<b>5</b>	<b>Revision history.....</b>	<b>15</b>

# 1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage	650	V
$V_{GS}$	Gate-source voltage	$\pm 25$	V
$I_D^{(1)}$	Drain current (continuous) at $T_C = 25^\circ\text{C}$	22.5	A
$I_D^{(1)}$	Drain current (continuous) at $T_C = 100^\circ\text{C}$	22	A
$I_{DM}^{(1)(2)}$	Drain current (pulsed)	90	A
$I_D^{(3)}$	Drain current (continuous) at $T_{pcb} = 25^\circ\text{C}$	4.3	A
$I_D^{(3)}$	Drain current (continuous) at $T_{pcb} = 100^\circ\text{C}$	2.7	A
$P_{TOT}^{(3)}$	Total dissipation at $T_{pcb} = 25^\circ\text{C}$	2.8	W
$P_{TOT}^{(1)}$	Total dissipation at $T_C = 25^\circ\text{C}$	189	W
$I_{AR}$	Avalanche current, repetitive or not repetitive (pulse width limited by $T_j$ max)	9	A
$E_{AS}$	Single pulse avalanche energy (starting $T_j = 25^\circ\text{C}$ , $I_D = I_{AR}$ , $V_{DD} = 50\text{ V}$ )	960	mJ
$dv/dt^{(4)}$	Peak diode recovery voltage slope	15	V/ns
$T_{stg}$	Storage temperature	- 55 to 150	$^\circ\text{C}$
$T_j$	Max. operating junction temperature	150	

**Notes:**(1) The value is rated according to  $R_{thj-case}$  rated and limited by package.

(2) Pulse width limited by safe operating area.

(3) When mounted on FR-4 board of 1 inch<sup>2</sup>, 2oz Cu.(4)  $I_{SD} \leq 22.5\text{ A}$ ,  $di/dt \leq 400\text{ A}/\mu\text{s}$ ;  $V_{DS(\text{peak})} < V_{(\text{BR})DSS}$ ,  $V_{DD} = 400\text{ V}$ .

Table 3: Thermal data

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case max	0.66	$^\circ\text{C/W}$
$R_{thj-pcb}^{(1)}$	Thermal resistance junction-pcb max	45	$^\circ\text{C/W}$

**Notes:**(1) When mounted on FR-4 board of 1 inch<sup>2</sup>, 2oz Cu.

## 2 Electrical characteristics

$T_C = 25^\circ\text{C}$  unless otherwise specified

Table 4: On/off states

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(\text{BR})\text{DSS}}$	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	650			V
$I_{DSS}$	Zero gate voltage Drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 650 \text{ V}$			1	$\mu\text{A}$
		$V_{GS} = 0 \text{ V}, V_{DS} = 650 \text{ V}, T_C = 125^\circ\text{C}$			100	$\mu\text{A}$
$I_{GSS}$	Gate-body leakage current	$V_{GS} = \pm 25 \text{ V}, V_{DS} = 0 \text{ V}$			$\pm 100$	nA
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	3	4	5	V
$R_{DS(\text{on})}$	Static drain-source on-resistance	$V_{GS} = 10 \text{ V}, I_D = 17.5 \text{ A}$		0.061	0.069	$\Omega$

Table 5: Dynamic

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{iss}$	Input capacitance	$V_{DS} = 100 \text{ V}, f = 1 \text{ MHz}, V_{GS} = 0 \text{ V}$	-	4200	-	pF
$C_{oss}$	Output capacitance		-	100	-	pF
$C_{rss}$	Reverse transfer capacitance		-	6	-	pF
$C_{o(er)}^{(1)}$	Equivalent output capacitance energy related	$V_{GS} = 0 \text{ V}, V_{DS} = 0 \text{ to } 80\% V_{(\text{BR})\text{DSS}}$	-	97	-	pF
$C_{o(tr)}^{(2)}$	Equivalent output capacitance time related		-	344	-	pF
$R_G$	Intrinsic gate resistance	$f = 1 \text{ MHz}, I_D = 0 \text{ A}$	-	1.4	-	$\Omega$
$Q_g$	Total gate charge	$V_{DD} = 520 \text{ V}, I_D = 17.5 \text{ A}, V_{GS} = 10 \text{ V}$ (see Figure 15: "Gate charge test circuit")	-	96	-	nC
$Q_{gs}$	Gate-source charge		-	24	-	nC
$Q_{gd}$	Gate-drain charge		-	40	-	nC

**Notes:**

<sup>(1)</sup> $C_{o(er)}$  is defined as a constant equivalent capacitance giving the same stored energy as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$

<sup>(2)</sup> $C_{o(tr)}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$

Table 6: Switching times

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(V)}$	Voltage delay time	$V_{DD} = 400 \text{ V}$ , $I_D = 22.5 \text{ A}$ $R_G = 4.7 \Omega$ , $V_{GS} = 10 \text{ V}$ (see <i>Figure 16: "Test circuit for inductive load switching and diode recovery times"</i> and <i>Figure 19: "Switching time waveform"</i> )	-	84	-	ns
$t_{r(V)}$	Voltage rise time		-	10.8	-	ns
$t_{f(i)}$	Crossing fall time		-	11	-	ns
$t_{C(off)}$	Crossing time		-	16.5	-	ns

Table 7: Source drain diode

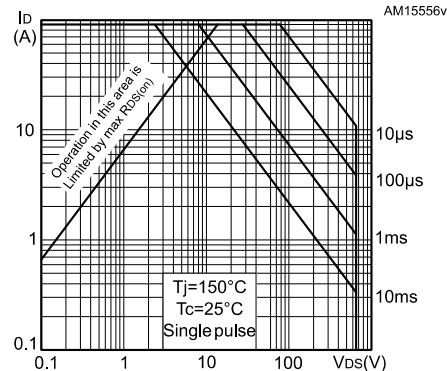
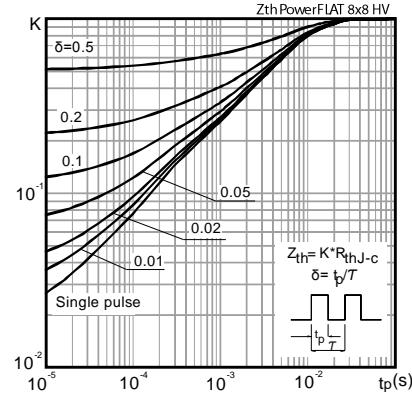
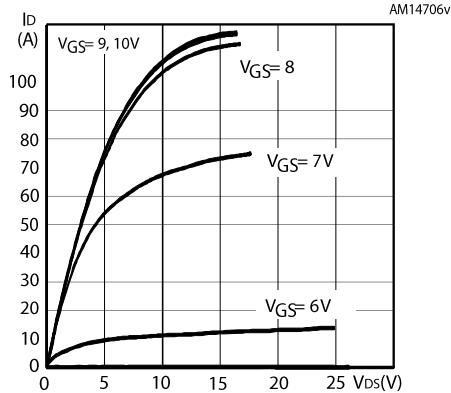
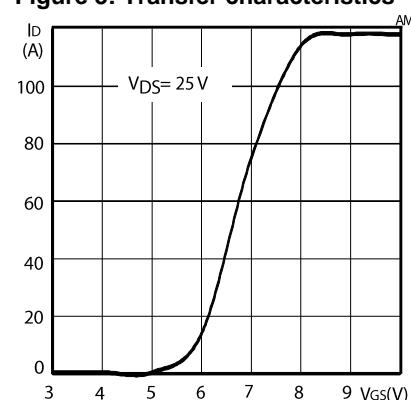
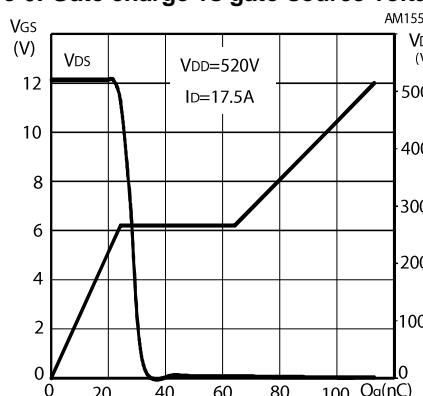
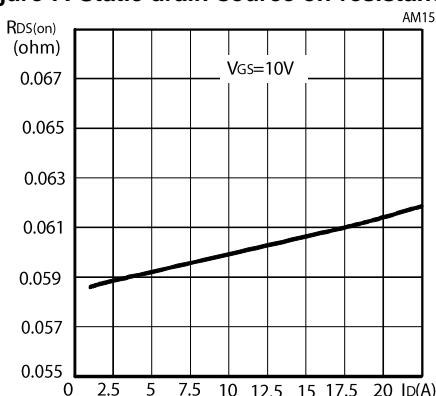
Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}^{(1)}$	Source-drain current		-		22.5	A
$I_{SDM}^{(1)(2)}$	Source-drain current (pulsed)		-		90	A
$V_{SD}^{(3)}$	Forward on voltage	$V_{GS} = 0 \text{ V}$ , $I_{SD} = 22.5 \text{ A}$	-		1.5	V
$t_{rr}$	Reverse recovery time	$I_{SD} = 22.5 \text{ A}$ , $dI/dt = 100 \text{ A}/\mu\text{s}$ , $V_{DD} = 100 \text{ V}$ (see <i>Figure 16: "Test circuit for inductive load switching and diode recovery times"</i> )	-	378		ns
$Q_{rr}$	Reverse recovery charge		-	7		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current		-	37		A
$t_{rr}$	Reverse recovery time		-	454		ns
$Q_{rr}$	Reverse recovery charge	$I_{SD} = 22.5 \text{ A}$ , $dI/dt = 100 \text{ A}/\mu\text{s}$ , $V_{DD} = 100 \text{ V}$ , $T_j = 150^\circ\text{C}$ (see <i>Figure 16: "Test circuit for inductive load switching and diode recovery times"</i> )	-	9.5		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current		-	42		A

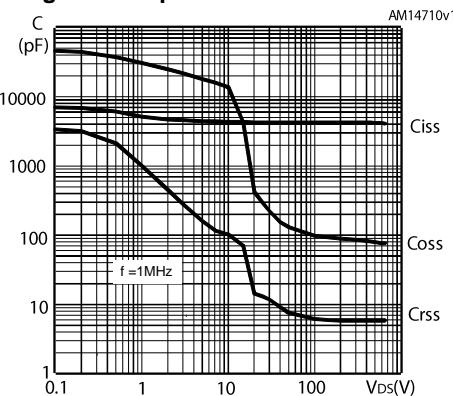
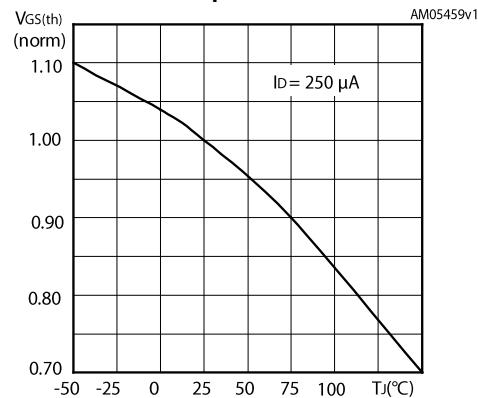
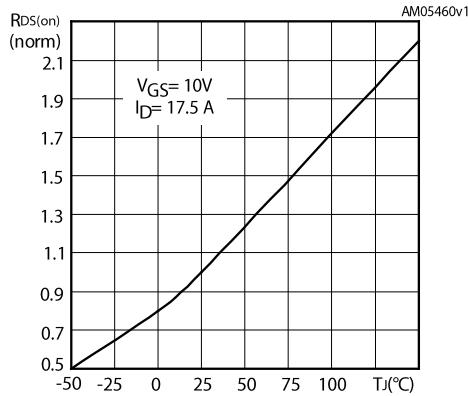
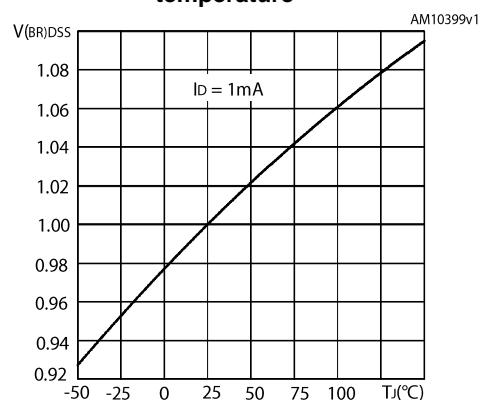
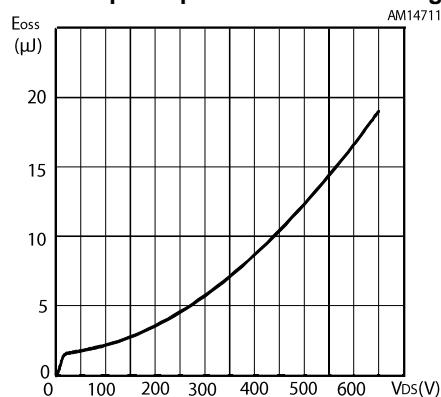
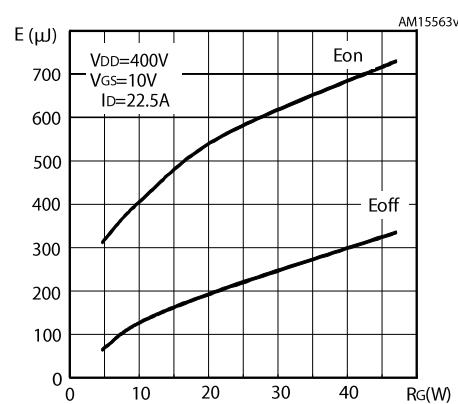
**Notes:**(1)The value is rated according to  $R_{thj-case}$  and limited by package.

(2)Pulse width is limited by safe operating area

(3)Pulsed: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%

## 2.1 Electrical characteristics (curves)

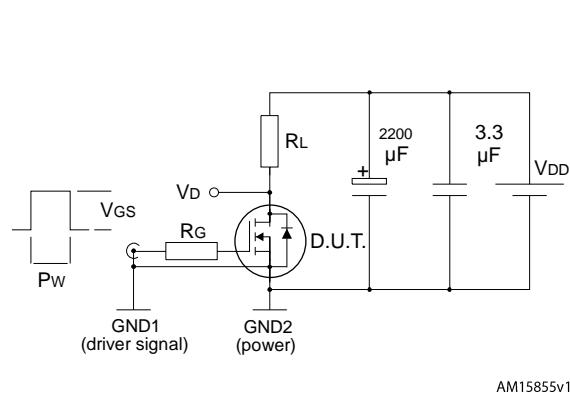
**Figure 2: Safe operating area****Figure 3: Thermal impedance****Figure 4: Output characteristics****Figure 5: Transfer characteristics****Figure 6: Gate charge vs gate-source voltage****Figure 7: Static drain-source on-resistance**

**Figure 8: Capacitance variations****Figure 9: Normalized gate threshold voltage vs temperature****Figure 10: Normalized on-resistance vs temperature****Figure 11: Normalized V(BR)DSS vs temperature****Figure 12: Output capacitance stored energy****Figure 13: Switching losses vs gate resistance**

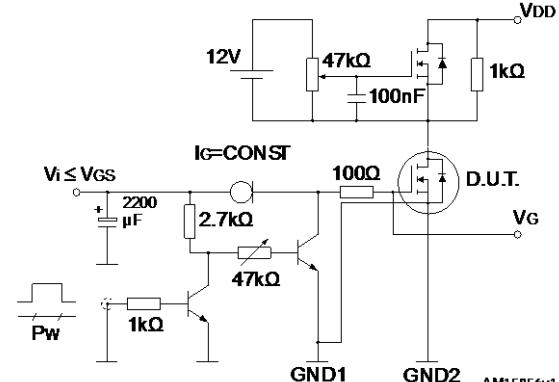
The previous figure  $E_{on}$  includes reverse recovery of a SiC diode.

### 3 Test circuits

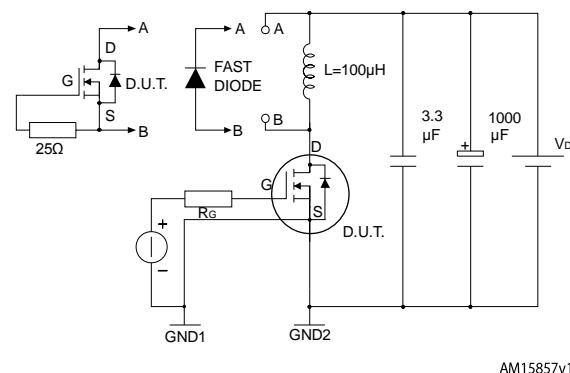
**Figure 14: Switching times test circuit for resistive load**



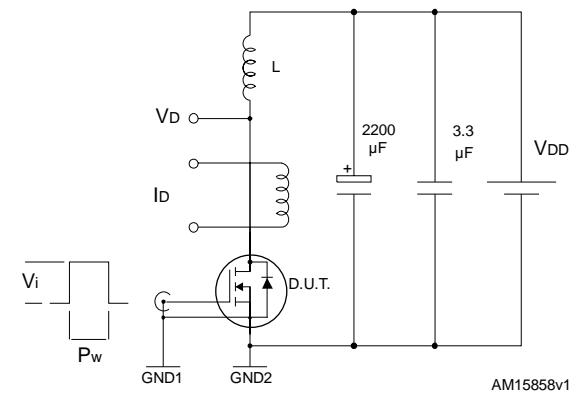
**Figure 15: Gate charge test circuit**



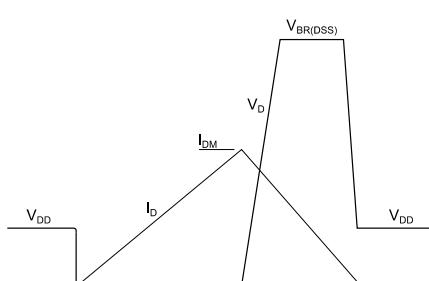
**Figure 16: Test circuit for inductive load switching and diode recovery times**



**Figure 17: Unclamped inductive load test circuit**

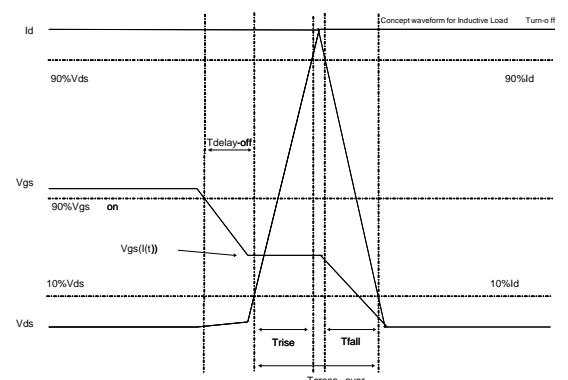


**Figure 18: Unclamped inductive waveform**



AM01472v1

**Figure 19: Switching time waveform**



AM05540v2

## 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com).  
ECOPACK® is an ST trademark.

## 4.1 PowerFLAT™ 8x8 HV package information

Figure 20: PowerFLAT™ 8x8 HV drawing

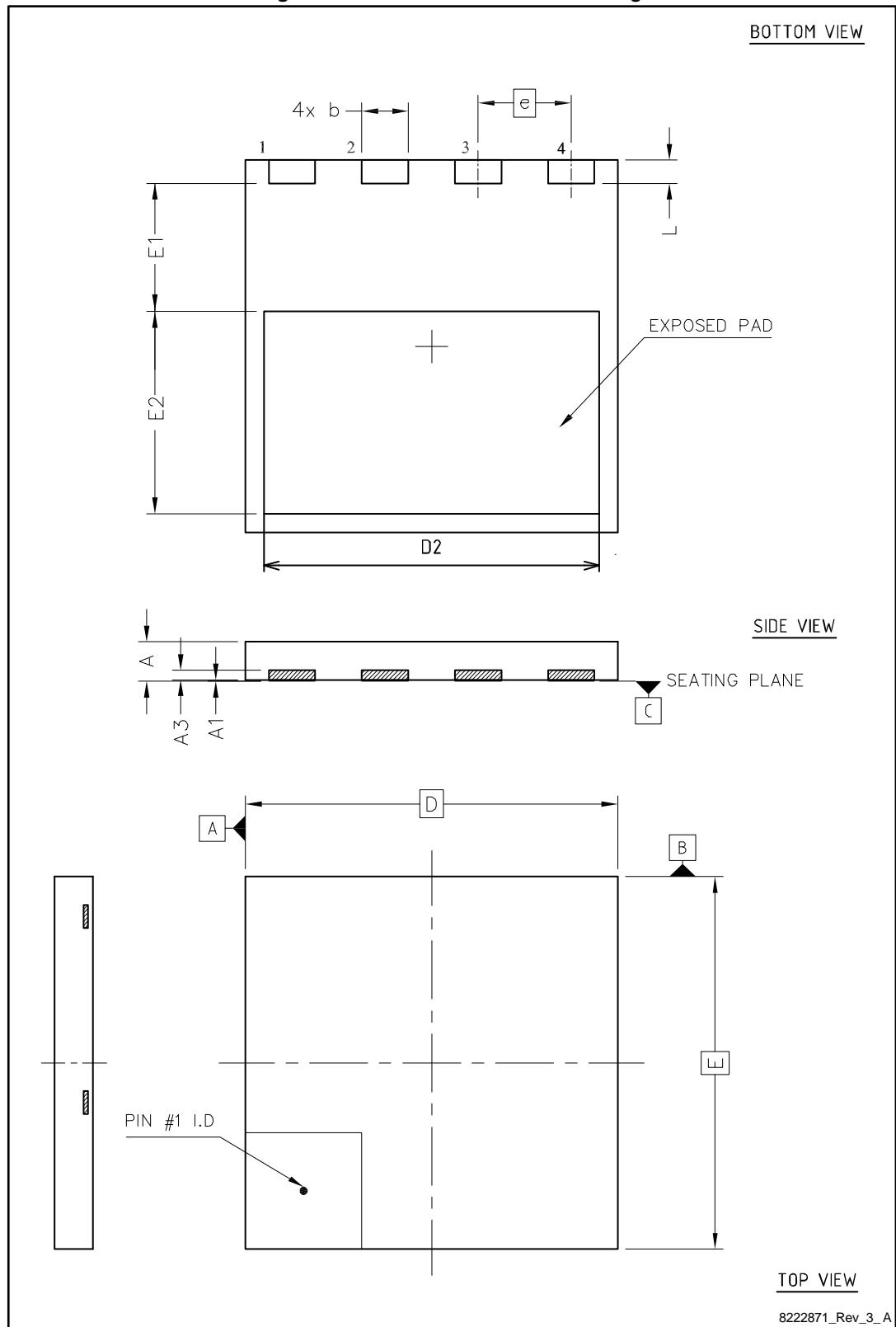
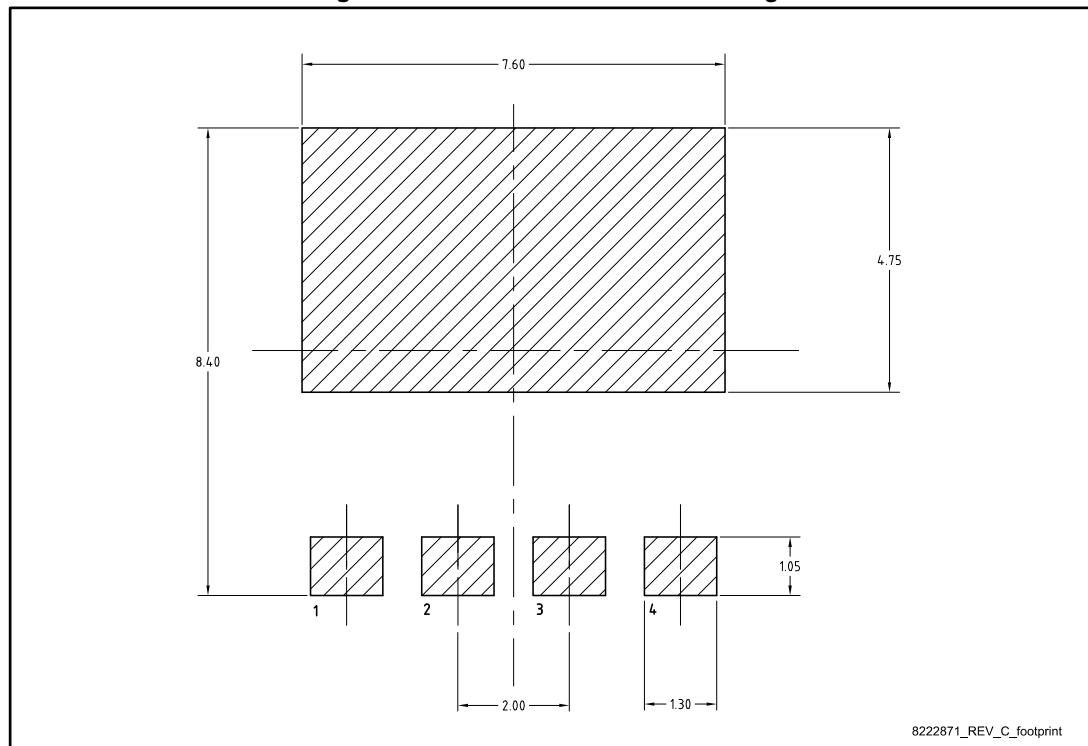


Table 8: PowerFLAT™ 8x8 HV mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	0.75	0.85	0.95
A1	0.00		0.05
A3	0.10	0.20	0.30
b	0.90	1.00	1.10
D	7.90	8.00	8.10
E	7.90	8.00	8.10
D2	7.10	7.20	7.30
E1	2.65	2.75	2.85
E2	4.25	4.35	4.45
e		2.00	
L	0.40	0.50	0.60

Figure 21: PowerFLAT™ 8x8 HV drawing



All dimensions are in millimeters.

## 4.2 PowerFLAT™ 8x8 HV packing information

Figure 22: PowerFLAT™ 8x8 HV tape

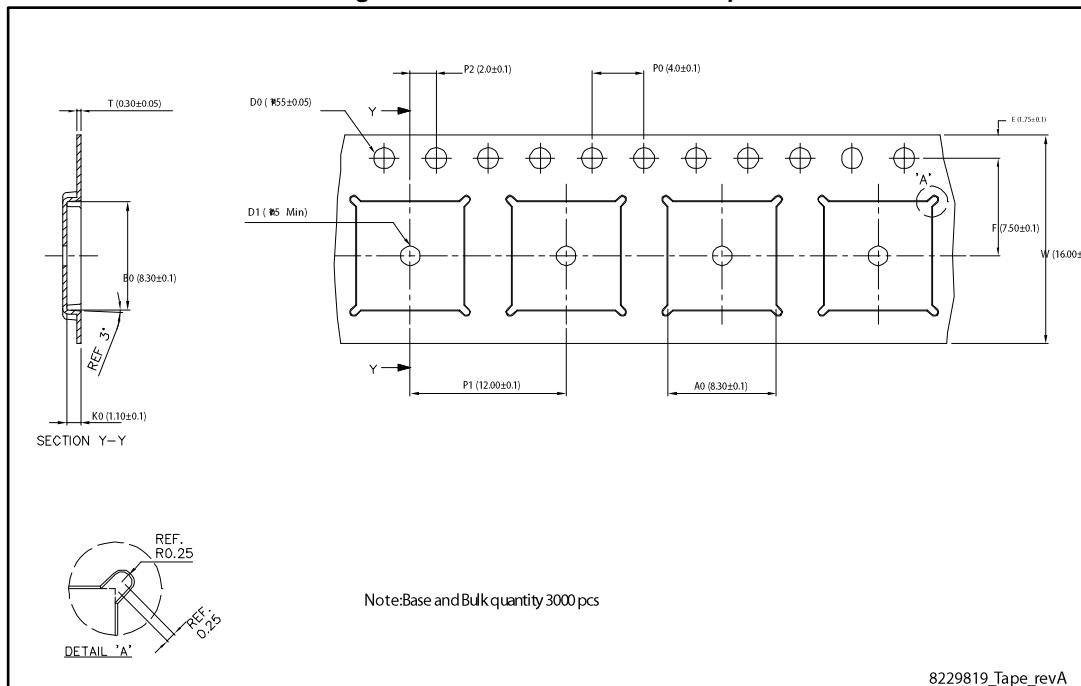


Figure 23: PowerFLAT™ 8x8 HV package orientation in carrier tape

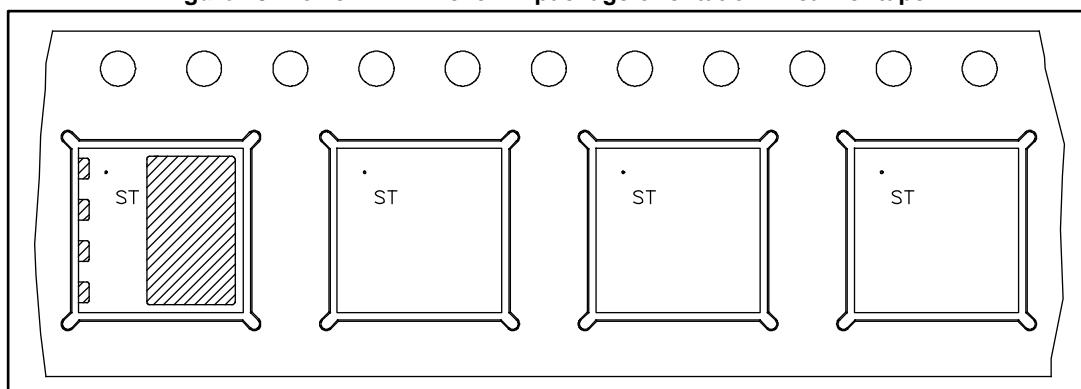
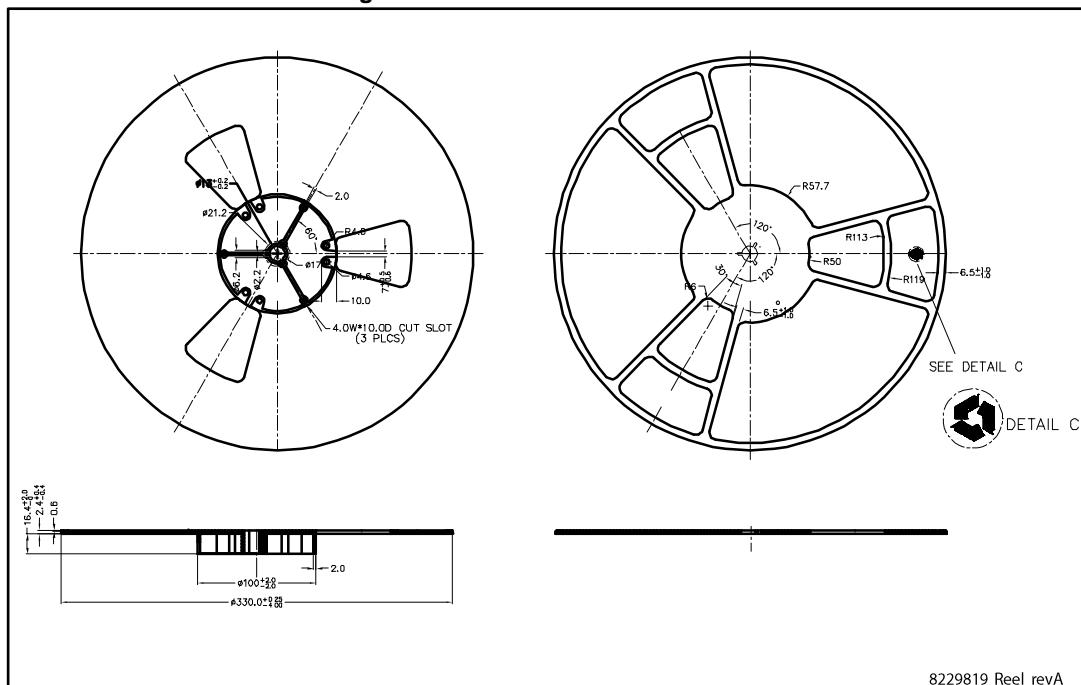


Figure 24: PowerFLAT™ 8x8 HV reel



## 5 Revision history

Table 9: Document revision history

Date	Revisi on	Changes
14-May-2012	1	First release.
25-Jan-2013	2	<ul style="list-style-type: none"> <li>-Modified ID value and note 1 on first page</li> <li>-Modified: <math>I_D</math>, <math>P_{TOT}</math>, <math>I_{AR}</math> values, and note1, 4 on Table 2</li> <li>-Modified: <math>R_{thj-case}</math> value on Table 3</li> <li>-Modified: <math>R_{DS(on)}</math> on Table 4</li> <li>-Modified: typical values on Table 5 and 6</li> <li>-Modified: typical and max values on Table 7</li> <li>-Inserted: Section 2.1: Electrical characteristics (curves)</li> <li>-Document status promoted from preliminary data to production data.</li> </ul>
09-Oct-2015	3	<p>Updated title, features and description  Text and formatting changes throughout document.</p> <p>Updated <i>Section 1: "Electrical ratings"</i> and <i>Section 2: "Electrical characteristics"</i></p> <p>Changes according to PCN9187:</p> <p>Updated package silhouette and figure <i>Figure 1: "Internal schematic diagram"</i> on cover page.</p> <p>Updated <i>Section 4.1: "PowerFLAT™ 8x8 HV package information"</i>.</p>

**IMPORTANT NOTICE – PLEASE READ CAREFULLY**

STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST's terms and conditions of sale in place at the time of order acknowledgement.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of Purchasers' products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2015 STMicroelectronics – All rights reserved